

Is Now Part of



ON Semiconductor®

To learn more about ON Semiconductor, please visit our website at www.onsemi.com

ON Semiconductor and the ON Semiconductor logo are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA Class 3 medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, emplo



June 2014

FDMC86240

N-Channel Shielded Gate PowerTrench[®] MOSFET 150 V, 16 A, 51 m Ω

Features

- Shielded Gate MOSFET Technology
- Max $r_{DS(on)} = 51 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 4.6 \text{ A}$
- Max $r_{DS(on)} = 70 \text{ m}\Omega$ at $V_{GS} = 6 \text{ V}$, $I_D = 3.9 \text{ A}$
- Low Profile 1 mm max in Power 33
- 100% UIL Tested
- RoHS Compliant



General Description

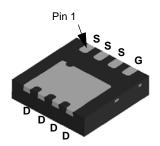
This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench® process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

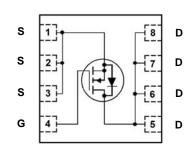
Application

■ DC - DC Conversion

Top Bottom







MLP 3.3x3.3

MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

| Symbol | Paramet | | Ratings | Units | |
|-----------------------------------|---|------------------------|-----------|-------------|----|
| V _{DS} | Drain to Source Voltage | | | 150 | V |
| V _{GS} | Gate to Source Voltage | | | ±20 | V |
| | Drain Current -Continuous | T _C = 25 °C | | 16 | |
| I _D | -Continuous | T _A = 25 °C | (Note 1a) | 4.6 | Α |
| | -Pulsed | | | 20 | |
| E _{AS} | Single Pulse Avalanche Energy | | (Note 3) | 34 | mJ |
| В | Power Dissipation | T _C = 25 °C | | 40 | W |
| P_{D} | Power Dissipation | T _A = 25 °C | (Note 1a) | 2.3 | VV |
| T _J , T _{STG} | Operating and Storage Junction Temperat | ure Range | | -55 to +150 | °C |

Thermal Characteristics

| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | 3.1 | °C/W |
|-----------------|---|-----|-------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1a) | 53 | *C/VV |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|-----------|----------|-----------|------------|------------|
| FDMC86240 | FDMC86240 | Power 33 | 13 " | 12 mm | 3000 units |

Electrical Characteristics T_J = 25 °C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|----------------------------------|--|---|-----|-----|------|-------|
| Off Chara | ncteristics | | | | | |
| BV_{DSS} | Drain to Source Breakdown Voltage | $I_D = 250 \mu A, V_{GS} = 0 V$ | 150 | | | V |
| $\Delta BV_{DSS} \ \Delta T_{J}$ | Breakdown Voltage Temperature Coefficient | I_D = 250 μ A, referenced to 25 °C | | 101 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 120 V, V _{GS} = 0 V | | | 1 | μΑ |
| I_{GSS} | Gate to Source Leakage Current | $V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | ±100 | nA |

On Characteristics

| $V_{GS(th)}$ | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_{D} = 250 \mu A$ | 2.0 | 2.9 | 4.0 | V |
|--------------------------------------|--|--|------|------|-----|-------|
| $\Delta V_{GS(th)} \over \Delta T_J$ | Gate to Source Threshold Voltage Temperature Coefficient | I_D = 250 μ A, referenced to 25 °C | | -9 | | mV/°C |
| | | $V_{GS} = 10 \text{ V}, I_D = 4.6 \text{ A}$ | | 44.7 | 51 | |
| r _{DS(on)} | r _{DS(on)} Static Drain to Source On Resistance | $V_{GS} = 6 \text{ V}, I_D = 3.9 \text{ A}$ | | 51.4 | 70 | mΩ |
| | $V_{GS} = 10 \text{ V}, I_D = 4.6 \text{ A}, T_J = 125 ^{\circ}\text{C}$ | | 84.5 | 97 | | |
| 9 _{FS} | Forward Transconductance | V _{DS} = 10 V, I _D = 4.6 A | | 15 | | S |

Dynamic Characteristics

| C _{iss} | Input Capacitance | V 75 V V 0 V | 680 | 905 | pF |
|------------------|------------------------------|--|-----|-----|----|
| Coss | Output Capacitance | $V_{DS} = 75 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz | 79 | 105 | pF |
| C _{rss} | Reverse Transfer Capacitance | 1 - 1 101112 | 4.3 | 10 | pF |
| R_q | Gate Resistance | | 0.5 | | Ω |

Switching Characteristics

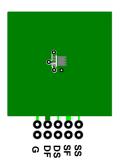
| t _{d(on)} | Turn-On Delay Time | | 8.2 | 17 | ns |
|---------------------|-------------------------------|--|-----|----|----|
| t _r | Rise Time | $V_{DD} = 75 \text{ V}, I_D = 4.6 \text{ A},$ | 1.7 | 10 | ns |
| t _{d(off)} | Turn-Off Delay Time | $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ | 14 | 26 | ns |
| t _f | Fall Time | | 3.1 | 10 | ns |
| $Q_{g(TOT)}$ | Total Gate Charge | V _{GS} = 0 V to 10 V | 11 | 15 | nC |
| $Q_{g(TOT)}$ | Total Gate Charge | $V_{GS} = 0 \text{ V to 5 V}$ $V_{DD} = 75 \text{ V},$ $I_{D} = 4.6 \text{ A}$ | 6 | 9 | nC |
| Q_{gs} | Total Gate Charge | I _D = 4.0 A | 2.8 | | nC |
| Q_{qd} | Gate to Drain "Miller" Charge | | 2.3 | | nC |

Drain-Source Diode Characteristics

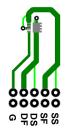
| Veb Source to Drain Dioge Forward Voltage | Source to Drain Diede, Ferward Voltage | $V_{GS} = 0 \text{ V}, I_{S} = 4.6 \text{ A}$ | (Note 2) | 0.79 | 1.3 | \/ |
|---|---|---|----------|------|-----|----|
| | $V_{GS} = 0 \text{ V}, I_{S} = 2 \text{ A}$ | (Note 2) | 0.75 | 1.2 | V | |
| t _{rr} | Reverse Recovery Time | | | 58 | 93 | ns |
| Q _{rr} | Reverse Recovery Charge | | | 63 | 102 | nC |

NOTES

^{1.} R_{0,1A} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{θ,JC} is guaranteed by design while R_{θ,CA} is determined by the user's board design.



53 °C/W when mounted on a 1 in² pad of 2 oz copper



125 °C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300 $\mu\text{s},$ Duty cycle < 2.0%.
- 3. Starting T $_J$ = 25 °C; N-ch: L = 3 mH, I $_{AS}$ = 4.8 A, V $_{DD}$ = 150 V, V $_{GS}$ = 10 V.

Typical Characteristics $T_J = 25$ °C unless otherwise noted

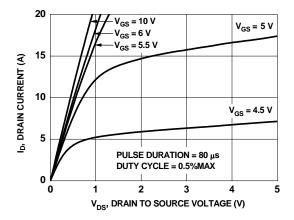


Figure 1. On-Region Characteristics

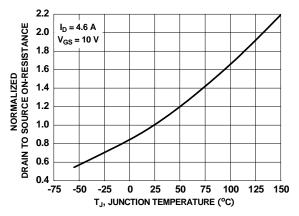


Figure 3. Normalized On-Resistance vs. Junction Temperature

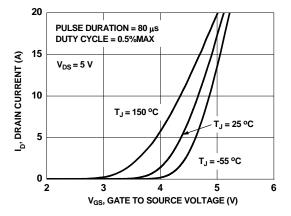


Figure 5. Transfer Characteristics

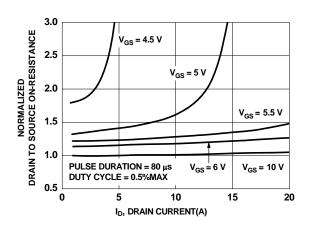


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

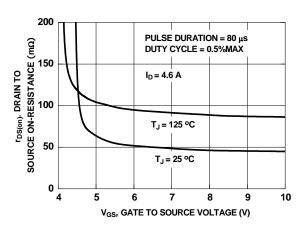


Figure 4. On-Resistance vs. Gate to Source Voltage

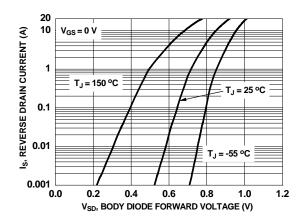


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

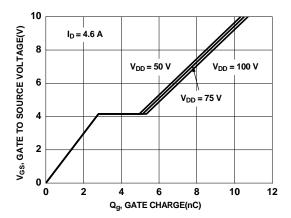


Figure 7. Gate Charge Characteristics

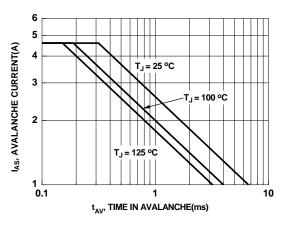


Figure 9. Unclamped Inductive Switching Capability

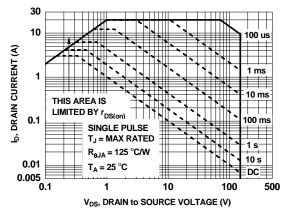


Figure 11. Forward Bias Safe Operating Area

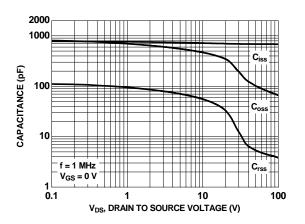


Figure 8. Capacitance vs. Drain to Source Voltage

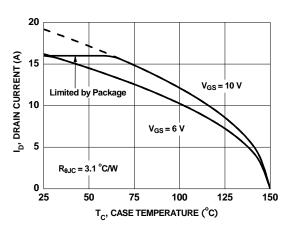


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

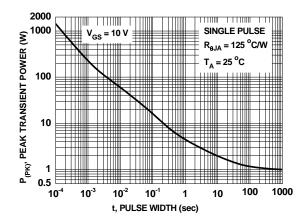


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics $T_J = 25$ °C unless otherwise noted

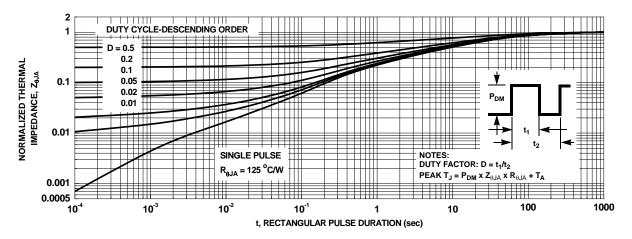
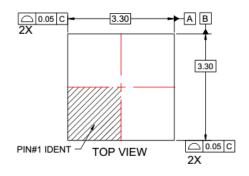
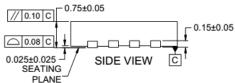
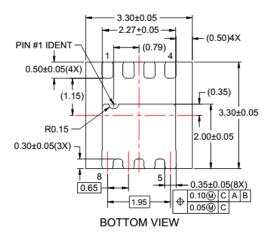


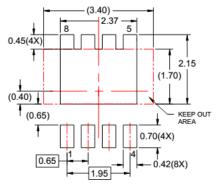
Figure 13. Transient Thermal Response Curve

Dimensional Outline and Pad Layout









RECOMMENDED LAND PATTERN

NOTES:

- A. DOES NOT CONFORM TO JEDEC REGISTRATION MO-229
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.
- E. DRAWING FILENAME: MKT-MLP08Srev3.



Package drawings are provided as a service to customers considering Fairchild components. Drawings may change in any manner without notice. Please note the revision and/or date on the drawing and contact a Fairchild Semiconductor representative to verify or obtain the most recent revision. Package specifications do not expand the terms of Fairchild's worldwide terms and conditions, specifically the warranty therein, which covers Fairchild products.

Always visit Fairchild Semiconductor's online packaging area for the most recent package drawings: http://www.fairchildsemi.com/package/packageDetails.html?id=PN_MLDEU-C08





TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

AccuPowerTM
AX-CAP^{®*}
BitSiCTM
Build it NowTM
CorePLUSTM
CorePOWERTM

COREPOWER IT CROSSVOLT TM

CTLTM

Current Transfer Logic TM

DEUXPEED®

Dual CoolTM
EcoSPARK[®]
EfficentMaxTM
ESBCTM

Fairchild[®]
Fairchild Semiconductor[®]
FACT Quiet SeriesTM
FACT[®]
FAST[®]
FastvCoreTM

F-PFS™ FRFET®

Global Power Resource $^{\text{SM}}$ GreenBridge $^{\text{TM}}$ Green FPS $^{\text{TM}}$

Green FPS™ e-Series™

Gmax[™] GTO[™] IntelliMAX[™] ISOPLANAR[™]

Marking Small Speakers Sound Louder and Better™

MegaBuck™ MICROCOUPLER™ MicroFET™ MicroPak™

MicroPak2™ MillerDrive™ MotionMax™ mWSaver® OptoHiT™ OPTOLOGIC® OPTOPLANAR® ® PowerTrench® PowerXS™

Programmable Active Droop™

QFET[®]
QS[™]
Quiet Series[™]
RapidConfigure[™]

Saving our world, 1mW/W/kW at a time™ SignalWise™

SmartMax[™] SMART START[™]

Solutions for Your Success™

STEALTH™
SuperFET®
SuperSOT™-3
SuperSOT™-6
SuperSOT™-8
SupreMOS®
SyncFET™

Sync-Lock™

SYSTEM ®*
GENERAL
TinyBoost®
TinyBuck®
TinyCalc™
TinyLogic®
TINYOPTO™
TinyPower™
TinyPWM™
TinyWire™
TranSiC™
TriFault Detect™
TRUECURRENT®*

SerDes*
UHC®
Ultra FRFET™
UniFET™
VCX™
VisualMax™
VoltagePlus™
XS™
4山童 ™

*Trademarks of System General Corporation, used under license by Fairchild Semiconductor.

DISCLAIMER

FETBench™

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used here in:

- Life support devices or systems are devices or systems which, (a) are
 intended for surgical implant into the body or (b) support or sustain life,
 and (c) whose failure to perform when properly used in accordance with
 instructions for use provided in the labeling, can be reasonably
 expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.Fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufactures of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed application, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handing and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address and warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors

PRODUCT STATUS DEFINITIONS Definition of Terms

| Datasheet Identification Product Status | | Definition |
|---|-------------------|---|
| Advance Information Formative / In Design | | Datasheet contains the design specifications for product development. Specifications may change in any manner without notice. |
| Preliminary First Production | | Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design. |
| No Identification Needed Full Production | | Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design. |
| Obsolete | Not In Production | Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only. |

Rev. 168

ON Semiconductor and in are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor and see no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and h

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada
Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910
Japan Customer Focus Center
Phone: 81–3–5817–1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative